CHARACTERIZATION OF PRE-TRANSITION OXIDES FORMED ON ZIRLO™

Ho Yeon Bae¹, Tae Ho Kim², Ji Hyun Kim², Chi Bum Bahn¹

¹School of Mechanical and Nuclear Engineering, Pusan National University (PNU), Busandaehak-ro 63Beon-gil, Geumjeong-gu Busan. 609-735, Republic of Korea
²School of Mechanical and Nuclear Engineering, Ulsan National Institute of Science and Technology (UNIST), 100 Banyeon-ri, Eonyang-eup, Ulju-gun, Ulsan. 689-798, Republic of Korea

ABSTRACT

Corrosion of zirconium fuel cladding is known to limit the lifetime and reloading cycles of the fuel in nuclear reactors. Oxide layers formed on ZIRLO™ cladding samples after immersion for 300-hour and 50-day in a simulated primary water chemistry condition (360 °C and 20 MPa) were analyzed by using the scanning transmission electron microscopy (STEM), in-situ transmission electron microscopy (in-situ TEM) with the focused ion beam (FIB) technique, and x-ray diffraction (XRD). It is interesting to note that both samples (immersion for 300-hour and 50-day) revealed the presence of the ZrO sub-oxide phase at the metal/oxide interface and columnar grains developed perpendicularly to the metal/oxide interface. Voids and micro-cracks were also detected near the water/oxide interface while relatively large lateral cracks were found just above less advanced metal/oxide interface. Equiaxed grains were mainly observed near the water/oxide interface.

Keywords: ZIRLO, oxide, pre-transition, primary water, in-situ transmission electron microscopy.

1.0 INTRODUCTION

Extensive studies have been conducted for a better understanding of corrosion and its failure mechanism of zirconium fuel cladding in nuclear reactors and thus prolong the lifetime and reloading cycles of the fuel for enhanced plant economics. Considerable amounts of researches have been devoted to understand the microstructure of Zr oxides formed in high temperature water or after post-irradiation treartment. It has well reported that a large variation in the width of ZrO sub-oxide phase at different metal/oxide interface locations was observed, suggesting that the transition is an extremely local process [1]. This oxide transition has been proposed to be contributed by accumulated stresses during oxide growth and interconnection of porosity [2]. The metal/oxide interface roughness was linked to the location of cracks [3], the formation of the cracks was also associated with the transition of the oxide [3,4] and large compressive stresses by the oxide volume expansion [5,6,7]. The cracks found in the oxide are mainly oriented parallel to the metal/oxide interface. Some researchers suggested that lateral cracks act as obstacles for diffusion of oxidizing species [8], while others assumed that they act as easy diffusion paths through surface diffusion [9]. Bossis et al. reported a porous outer layer in a pre-transition oxide analyzed by a secondary ion mass spectrometry (SIMS) and an electrical impedance spectroscopy (EIS) [3]. Cox et al. anticipated that porosity provides connected paths between the external oxidizing medium and the underlying metal [10]. Ni et al. reported the interconnected nano-pores along with grain boundaries in the oxide and concluded that development of interlinked porosity down to the metal/oxide interface is a key mechanism for the transition in oxidation kinetics [1]. Gong et al. also reported nano-pores in strings formed on Zr-Nb-Y alloy and N18 alloy (Zr-0.39Nb-0.93Sn-0.31Fe-0.08Cr-0.048O) at grain boundaries and they suggested that initiation mechanism of porosity is Kirkendall effect [11]. In the oxide, columnar grains are more dominant in inner part and equiaxed grains are frequently observed at oxide surface.
It also appears that larger columnar grains have better corrosion resistance than smaller equiaxed grains [12, 13, 14]. Gabory et al. showed large amorphous ZrFeNb precipitates which were observed far away (700 nm) from the metal/oxide interface, while closest small amorphous β-Nb precipitates were found at 400 nm position from the metal/oxide interface in ZIRLO™ samples and deduced that large ZrFeNb precipitates can stay unoxidized longer in the oxide than the smaller β-Nb precipitates [15]. Tejlund and Andrén suggested crack initiation mechanism at second phase particle (SPP) [16]. We report here microscopic examination of pre-transition oxide formed on ZIRLO™ cladding tube samples by using scanning transmission electron microscopy (STEM), in-situ transmission electron microscopy (in-situ TEM) with focused ion beam (FIB) technique, and x-ray diffraction (XRD).

2.0 MATERIALS AND TECHNIQUES

Commercial zirconium alloy, ZIRLO™ tube has been oxidized in an autoclave connected to a recirculation water loop at 360 °C and 20 MPa for 300-hour and 50-day under a simulated primary water chemistry condition (pure H₂O with dissolved hydrogen of 30 cc/kg, 2 ppm Li as LiOH and 1200 ppm B as H₃BO₃). The pressure difference between interior and exterior of the cladding sample was maintained at 11.7 MPa by pressurizing argon gas to 4.56 MPa at room temperature (RT) during the exposure in the recirculation loop in order to simulate the compressive stress condition in the actual fuel cladding. Nominal chemical composition and dimension of test sample is given in Table 1. After a corrosion test, a protective coating of platinum was deposited on the oxide surface, and then in-situ lift-out FIB sectioning was carried out on a FEI Quanta 3D FEG, instrument operated at 2-30 kV, with currents between 1 pA and 65 nA to prepare TEM thin foils. STEM observations were carried out on a high resolution transmission electron microscope JEM-2100F (JEOL) at operated 200 kV. The oxygen content at the metal/oxide interface and composition of second-phase particle (SPP) were characterized, respectively, by an energy dispersive x-ray spectroscopy (EDS) line profile and elemental mapping. TEM analysis was performed at RT and 360 °C on JEM-3011 (JEOL) at operated 300 kV. Run-time of temperature rising from 25 °C to 75 °C and from 75 °C to 100 °C was 3 min and from 100 °C to 360 °C was 75 min, followed by the holding at 360 °C for 15 min. Since all samples showed a single oxide layer, it was expected to be a pre-transition oxide. XRD measurements were also conducted with cross-section of bulk ZIRLO™ tube samples using a Bruker D8 ADVANCE instrument to characterize crystal structures.

3.0 EXPERIMENTAL RESULTS

3.1 Oxide Morphology

Cross-section view of oxide formed in 360 °C water for 300-hour and 50-day is shown in Figure 1 and an average oxide thickness is estimated to be 0.96 μm and 1.86 μm, respectively. Before corrosion immersion test, an air-formed oxide thickness is < 10 nm. Table 2 shows the standard deviation of oxide thickness formed on each sample, indicating that the interface undulation increases with the exposure time during the pre-transition stage. These results are in good agreement with other study conducted under similar water chemistry conditions (simulated primary water condition, 2 ppm Li as LiOH and 1000 ppm B as H₃BO₃) [17]. The entire oxide layer is presented in Fig. 1. Large lateral cracks related to undulating metal/oxide interface can be clearly seen just above the interface summit in the oxide formed on both 300-hour and 50-day samples in red circles. It should be noted, however, that the width of these large cracks could be extended during the FIB process. Columnar oxide grains near the metal/oxide interface as well as equiaxed grains near the water/oxide interface can be observed at high resolution TEM images of a later section. It seems that cracks tend to have crescent shape in the outer oxide and number of cracks increase with exposure time. Precipitates are clearly seen near the metal/oxide interface in both 300-hour and 50-day images, but as approaching closer to the water/oxide interface, they are gradually amorphized.
3.2 Metal/Oxide Interface

Dark-field TEM images of 300-hour sample showed some local faint area along the metal/oxide interface. EDS line profile of one faint area is given in Figs. 2(a) and (b). Since the faint area has Zr:O ratio of 1:1 (between 45 and 55 at.%), this area is assumed as ZrO sub-oxide layer which has about 20 nm width. EDS line profile at the interface that does not contain the sub-oxide layer is shown in Figs. 2(c) and (d). On the contrary, the metal/oxide interface shown in Fig. 2(c) has a rapid change of Zr:O ratio. This sub-oxide layer also appears in 50-day corroded samples (Fig. 2(e)). However, there is a possibility that faint area (believed to be sub-oxide) is a region where metal and oxide overlaps. To unambiguously confirm the presence of sub-oxide layer other analyzing methods may have to be used, such as electron energy loss spectroscopy (EELS) [1] or microbeam synchrotron radiation diffraction and fluorescence techniques [18]. Ni et al. showed ~40 nm thick stoichiometry ZrO layer containing unidentified grains at the metal/oxide interface of 100-day corroded ZIRLO™ recrystallized sample [1]. Dominance of columnar oxide grains near the metal/oxide interface without porosity, as shown in Fig. 3, indicates the high resistance to corrosion of the oxide formed on 300-hour sample (very early pre-transition sample).

Fig. 4(a) shows an average value of oxide thickness formed on 300-hour sample measured at different locations in the presence of three types of lateral cracks. In order to characterize the oxide nature of 300-hour sample, three FIB thin foils with the total length of about 30 μm were prepared. Each form of three types of lateral crack is indicated within plots. It clearly shows that an average oxide thickness under a large crack (> 500 nm length) is much thinner than overall average oxide thickness. Crack position is known to be related with undulated interface induced by less advanced oxide. Parise et al. presented stress distribution of undulated interface through metal-oxide system modeling during Zr alloy oxidation. They showed high tensile stress just above interface summit working perpendicular to metal/oxide interface and proposed that this tensile stress is cause of lateral cracks frequently seen above interface summit [19]. However, the oxide thickness under small cracks, singly or together (< 320 nm length) near the metal/oxide interface is comparable with the average value in the 300-hour samples. Fig. 4(b) shows an average oxide thickness of 50-day sample. As shown in Fig. 4(b), the oxide thickness even under the large crack was not much different from the average value, which is inconsistent with the observation in the 300-day samples. However, the large crack in the 50-day sample was still formed just above the locally less advanced oxide interface. More analysis with multiple 50-day corroded samples is needed to draw a concrete conclusion.

3.3 Water/Oxide Interface

Figure 5 shows the high resolution TEM images of oxide near the water/oxide interface. In the outer oxide of 300-hour sample, equiaxed oxide grains and some voids which seem to be interlinked are clearly seen in Fig. 5(a). Outer oxide image of 50-day sample is shown in Figure 5(b), outermost equiaxed oxide grains with columnar oxide are observed. Figure 6 shows the XRD spectra of cross-section of bulk ZIRLO™ tube sample tested for 300-hour and 50-day. XRD data shows a minute peak of tetragonal ZrO₂ near 30° in 2-θ. Peak intensities of monoclinic and tetragonal phases become stronger as the sample exposure time to high temperature water increases. However, α-Zr and monoclinic ZrO₂ peaks are predominantly present, but zirconium hydride peak is not detected. One can thus postulate that 300-hour and 50-day immersion in 360 °C may not be enough to form zirconium hydride or the volume of zirconium hydride may be too small to be detected. By analyzing sliced bulk ZIRLO™ tube samples, the average hydrogen concentration in 300-hour and 50-day corroded sample was estimated around 2 ppm, which is below the solubility limit.

Figure 7 shows TEM bright/dark-field images of the oxide near the water/oxide interface. In dark-field images of 300-hour sample (Fig. 7(b)), white and black spots are observed. Some black spots of dark-field images turn into white appearances on bright-field images (red circles) and others do not. Therefore,
it is believed that some are voids and others are amorphized precipitates (blue circle). Outer oxide dark-field images of 50-day sample also clearly reveal some porosity with a crescent shape (see Fig. 7(d)). White spots in Fig. 7(b) could be caused by a TEM beam during its operation, and artifact during sample preparation using a FIB technique can be remained. More technical discussion on this damage or artifact is described later.

### 3.4 Precipitates

Two types of precipitates are mainly observed in 300-hour and 50-day corroded ZIRLO™ tube samples. They are $\beta$-Nb and ZrFeNb precipitates. ZrFeNb precipitate is bigger than $\beta$-Nb precipitate, Fig. 8(a) shows smaller $\beta$-Nb precipitates in 300-hour sample oxide near the metal/oxide interface. A few cracks are observed near or on top of precipitates, which may be an artifact during FIB process. Figure 8(c) shows a large ZrFeNb precipitate located at the metal/oxide interface and a similar presence and location of crack are observed. The distance between outermost non-amorphized precipitate and the metal/oxide interface is estimated to be 400 nm for 300-hour corroded samples. Figure 9 shows TEM images of 50-day corroded sample oxide. It should be noted that a crack is present on top of some precipitates (red circles) but others do not (blue circles). Therefore, we conclude that cracks located on top of precipitate are formed during the sample preparation by the FIB technique, nevertheless, a theoretical mechanism of the crack initiation on top of the precipitates was suggested [16].

### 3.5 In-Situ TEM Observation

All microscopic examination described above was conducted at room temperature. Since the oxidation process occurred at 360°C, it is worthwhile to raise the specimen temperature to 360°C and observe if there would be any change in the microstructure, which has been conducted by Kim et al. [20]. Figures 10(a) and (b) show the effect of TEM operating temperatures between RT and 360°C on 300-hour sample oxide near the water/oxide interface, showing little contrast change, as well as some voids which seem to be interlinked. Contrast change and voids are also identified on 50-day sample (Figs. 10(c) and (d)). Kim et al. suggested that the contrast change is caused by the different thermal expansion behaviors between zirconium matrix and oxide due to lower coefficient of linear thermal expansion of zirconium compared with that of zirconium oxide [20]. The little contrast change could be also caused by sample bending during temperature rising. The contrast change was barely noticeable on TEM images of the 50-day sample oxide near the metal/oxide interface, as shown in Fig. 11. The heating and cooling cycle caused no significant change in the microstructure near the metal/oxide interface except the contrast change, although this observation needs to be supported by higher resolution TEM images. The micro-crack (or cavity) on top of precipitates showed no significant change during the heating and cooling cycle. The damage area composed of a crack network also did not show noticeable change.

### 4.0 DISCUSSION

By examining oxide formed on ZIRLO™ tube samples which are corroded in 360 °C water in a PWR primary water for the early (300-hour) and mid (50-day) pre-transition, oxide morphologies, phases, and microstructures at each pre-transition stage are examined. Such examinations for the early pre-transition stage have not been reported well in literatures.

Some researchers proposed that the interlinked porosity at grain boundaries plays an important role for the transition in oxidation kinetics [1,11]. In our samples, some voids, which seem to be interlinked, were observed in the oxide near the water/oxide interface. However, some of them may be artifact formed during sample preparation by the FIB process or beam damage during TEM operation. Therefore, in order to inspect the possible formation of voids by sample preparation, we performed an additional EDS element mapping of Ga from the water/oxide interface to the metal/oxide interface of the 50-day corroded sample because Ga ions was used during the FIB process. TEM images and EDS results are shown in Fig. 12. If voids are artifact formed during the thin foil preparation by FIB process, Ga concentration through
EDS element mapping could show local hot spots where voids are observed. However, from the water/oxide interface to the metal/oxide interface, Ga concentration appears to be uniform in the oxide layer. Figure 13 shows the distribution of white spots, indicating typical TEM beam damages by high voltage TEM operation at the metal/oxide interface valley region in the 50-day corroded sample. Therefore, it suggests that voids are formed during the actual oxidation process, however more study is needed for a better understanding of void formation and also plausible mechanisms for the void formation (for example, impurity dissolution).

Other researchers suggested a correlation between transition time and compressive hoop stress in the oxide layer and carried out modeling based on stress [19,21]. Lateral cracks are often observed in the oxide and on top of precipitates, especially a very large lateral crack is found just above the metal/oxide interface summit. It strongly suggests that the undulated metal/oxide interface induced less advanced oxide, which in turn leads to crack formation. Parise et al. [19] showed basis of this assumption through stress distribution modeling about undulated metal/oxide interface. Tejland and Andrén [16] suggested a crack initiation mechanism at top of SPP. However, these cracks might be susceptible to be widened during the sectioning by the FIB technique. On the contrary, crescent shape cracks (or cavities) are observed in the oxide near the water/oxide interface. Undulation of the metal/oxide interface causing unstable stress state is believed to generate lateral cracks near the metal/oxide interface summit, whereas the cause of formation of crescent shape cracks (or cavities) near the water/oxide interface is not well known. It is thus planned to analyze the 100-day corroded ZIRLO™ cladding samples and be compared with 300-hour and 50-day corroded pre-transition samples. If 100-day sample shows increased number density of cavities or micro-cracks at water/oxide interface, then this may suggest that cavities or micro-cracks are not just artifact by the FIB sectioning but formed during oxidation process.

5.0 CONCLUSIONS

Microscopic examinations by STEM, in-situ FIB-TEM, and XRD were conducted to characterize the oxide formed on ZIRLO™ cladding tube samples oxidized in an autoclave of a recirculation loop at 360 °C and 20 MPa for 300-hour and 50-day under a simulated primary water chemistry conditions. The main conclusions are as follows:

- The 300-hour and 50-day corroded samples show an average oxide thickness 0.96 μm and 1.86 μm, respectively. Lateral cracks and columnar grains are dominant near the metal/oxide interface while crescent shape cracks (or cavities) and equiaxed grains are dominant near the water/oxide interface. Large lateral crack and band of large cracks are observed respectively just above the metal/oxide interface summit where is least advanced in 300-hour and 50-day corroded samples. However, it is possible that the width of these cracks was further enlarged during the thin foil preparation by the FIB process.

- Local sub-oxide layer is shown as faint area on dark-field TEM image along the metal/oxide interface and it has Zr:O ratio of 1:1 (between 45 and 55 at.%) with about 20 nm width in 300-hour corroded samples. This sub-oxide layer also appears in 50-day corroded samples. However, there is a possibility that faint area (believed to be sub-oxide) is a region where metal and oxide overlaps.

- Some voids are observed in the oxide near water/oxide interface on both early (300-hour) and mid (50-day) pre-transition samples. As approaching close to the metal/oxide interface, the number density of voids tends to decrease. These voids appear to be actual defects formed/grown during the oxidation process rather than TEM beam damage or artifact by the FIB process. However, further analysis is needed to clarify this.

- β-Nb precipitate and ZrFeNb precipitate are mainly observed. ZrFeNb precipitate is bigger than β-Nb precipitate. Cracks are formed on top of both precipitates in 300-hour corroded samples, but in 50-day corroded samples, cracks are formed on top of some precipitates, not all ones. This suggests that the
crack located on top of precipitate could be an artifact formed during the sample preparation by the FIB process. The distance between outermost non-amorphized precipitate and the metal/oxide interface was 400 nm.

- XRD data taken from cross-section of bulk ZIRLO™ tube sample predominantly consist of \(\alpha\)-Zr and monoclinic ZrO\(_2\) phases. A minute peak of tetragonal ZrO\(_2\) is detected and intensities of these peaks become stronger when exposure time increases. However, zirconium hydride peak is not detected. It is assumed that 300-hour and 50-day corrosion time in 360 °C may not be enough to form zirconium hydride or the volume of zirconium hydride may be formed too small to be detected. By analyzing sliced bulk ZIRLO™ tube samples, the average hydrogen concentration in 300-hour and 50-day corroded sample was estimated around 2 ppm, which is below the solubility limit.

- The oxide near the metal/oxide interface shows little contrast change analyzed between at RT and at 360 °C. This contrast change is believed to be contributed by the different thermal expansion behaviors between zirconium matrix and zirconium oxide or sample bending during temperature rising. However, the micro-crack (or cavity) on top of precipitates shows no significant change during the heating and cooling cycle. The damage area composed of a crack network also showed no noticeable change.

ACKNOWLEDGEMENTS

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REFERENCES


Table. 1 ZIRLO™ tube samples investigated in this work.

<table>
<thead>
<tr>
<th>Composition (wt.%)</th>
<th>Nb</th>
<th>Sn</th>
<th>O</th>
<th>Fe</th>
<th>C</th>
<th>N</th>
<th>Hf</th>
<th>Zr</th>
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<tr>
<td></td>
<td>0.96</td>
<td>0.76</td>
<td>0.62</td>
<td>0.18</td>
<td>0.1</td>
<td>0.03</td>
<td>0.002</td>
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<table>
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<tr>
<th>Dimension (mm)</th>
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<td></td>
<td>Inner diameter</td>
<td>8.3</td>
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<tr>
<td></td>
<td>Thickness</td>
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Table. 2 Standard deviation of oxide formed on 300-hour and 50-day corroded samples.

<table>
<thead>
<tr>
<th></th>
<th>Average thickness (nm)</th>
<th>Standard deviation (nm)</th>
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<tbody>
<tr>
<td>300-hour</td>
<td>960</td>
<td>87.62</td>
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<tr>
<td>50-day</td>
<td>1860</td>
<td>119.81</td>
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Fig. 1 (a) Bright-field STEM images showing the oxide layer of 300-hour corroded sample. (b) Dark-field panorama images of (a). (c) Bright-field STEM image showing the oxide of 50-day corroded sample. (d) Dark-field image of (c).

Fig. 2 (a) Dark-field TEM image of 300-hour sample showing the faint area at the metal/oxide interface. (b) EDS line profile data of (c) Dark-field TEM image of 300-hour sample showing the clear metal/oxide interface. (d) EDS line profile data of (c). (e) Dark-field TEM image of 50-day sample showing the faint area at the metal/oxide interface.
Fig. 3 Bright-field TEM image showing columnar oxide grains along the metal/oxide interface.

Fig. 4 (a) Average oxide thickness on the 300-hour sample and under three types of lateral crack. (b) Average oxide thickness on the 50-day sample and under three types of lateral cracks.
Fig. 5 (a) High resolution TEM images of 300-hour sample showing equiaxed oxide grains and some interlinked voids at the water/oxide interface. (b) STEM image of outer oxide formed on 50-day sample.

Fig. 6 XRD data taken from 300-hour and 50-day corroded cross-section of bulk ZIRLO™ tube sample.
Fig. 7 (a) Bright-field TEM images of 300-hour sample oxide near the water/oxide interface. (b) Dark-field panorama images of (a). (c) Bright-field panorama STEM images of 50-day sample oxide near water/oxide interface. (d) Dark-field panorama images of (c). Red and blue circles indicate respectively voids and amorphous precipitate.
Fig. 8 (a) Smaller $\beta$-Nb precipitates with a crack on top in 300-hour sample oxide near metal/oxide interface. (b) EDS mapping of (a). (c) Bigger ZrFeNb precipitates in 300-hour sample oxide at the metal/oxide interface. $\beta$-Nb precipitates are also observed in Zr matrix region. (d) EDS mapping of (c). (e) ZrFeNb precipitate in 300-hour sample oxide showing clearly a crack on top. Every precipitate in 300-hour sample oxide had a crack on top. The cracks located on top of precipitate could be formed during the sample preparation by the FIB technique.

Fig. 9 Precipitates in the oxide formed on 50-day corroded sample. Some have a crack on top (red circles) but others do not (blue circles).
Fig. 10 (a) TEM images of outer oxide formed on 300-hour corroded sample at RT. (b) Images of (a) at 360 °C in same location. (c) TEM images of outer oxide formed on 50-day corroded sample at RT. (d) Images of (c) at 360 °C in same location.
Fig. 11 (a) TEM image of metal/oxide interface of 50-day corroded sample at RT. (b) Images of (a) at 360 °C in same location. (c) After cooling from 360 °C of (b) in same location. This contrast change is believed to be contributed by the different thermal expansion behaviors between zirconium matrix and zirconium oxide or sample bending during temperature rising.

Fig. 12 EDS element mapping of Ga ion for 50-day corroded sample from the water/oxide interface to metal/oxide interface.
Fig. 13 STEM dark-field image showing typical TEM beam damage by high voltage TEM operation at the metal/oxide interface valley region in 50-day corroded sample.